

Search Notes**Application/Control No.**

10/792,209

Examiner

SHAWN AN

Applicant(s)/Patent under Reexamination

CHOI ET AL.

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
375	240.12	5/13/2008	SA
	240.26		SA
	240.25		SA
382	235		SA
	233		SA
348	21		SA
	614		SA
	607		SA

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner